## Notice of References Cited

Application/Control No.

O9/546,213

Applicant(s)/Patent Under Reexamination WATANABE ET AL.

Examiner

Ryan J Hesseltine

Applicant(s)/Patent Under Reexamination WATANABE ET AL.

Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code			Classification
	Α	US-4,187,051	02-1980	Kirsch et al.	414/744.3
	В	US-4,909,376	03-1990	Herndon et al.	198/395
	C	US-5,446,835 A	08-1995	lida et al.	700/259
	D	US-5,621,807 A	04-1997	Eibert et al.	382/103
	E	US-5,790,687	08-1998	McLaughlin et al.	382/111
	F	US-5,987,591 A	11-1999	Jyumonji, Takashi	700/259
	G	US-6,349,245 B1	02-2002	Finlay, Patrick Armstrong	700/245
	Н	US-6,490,369 B1	12-2002	Beiman, Leonard H.	382/153
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2123172 A	01-1984	United Kingdom	ARCHIBALD et al.	G05B 19/42
	0	JP 02110788 A	04-1990	Japan	KOISO et al.	G06F 15/70
A	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.